## Notice of References Cited Application/Control No. O9/839,510 Examiner Harry Vartanian Applicant(s)/Patent Under Reexamination SPARRMAN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,760,315	07-2004	Esmailzadeh et al.	370/310
	В	US-6,661,835	12-2003	Sugimoto et al.	375/148
	C	US-6,473,415	10-2002	Kim et al.	370/342
	D	US-6,067,333	05-2000	Kim et al.	375/346
	E	US-5,724,378	03-1998	Miki et al.	375/148
	F	US-6,741,634	05-2004	Kim et al.	375/144
	G	US-6,404,759	06-2002	Shoji, Takashi	370/342
	Н	US-6,282,233	08-2001	Yoshida, Shousei	375/148
	ı	US-6,212,223	04-2001	Okamoto, Naoki	375/150
	J	US-6,667,964	12-2003	Seki et al.	370/342
	κ	US-2002/0131534	09-2002	Ariyoshi et al.	375/346
	L	US-2002/0061080	05-2002	Richards et al.	375/346
	М	US-		·	:

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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